

HR(0-10°,1000-1130±8nm)>99.9%, GDD(0-10°,1030nm)~ -1000±100fs²

fig. 1 reflection HR-region 10°

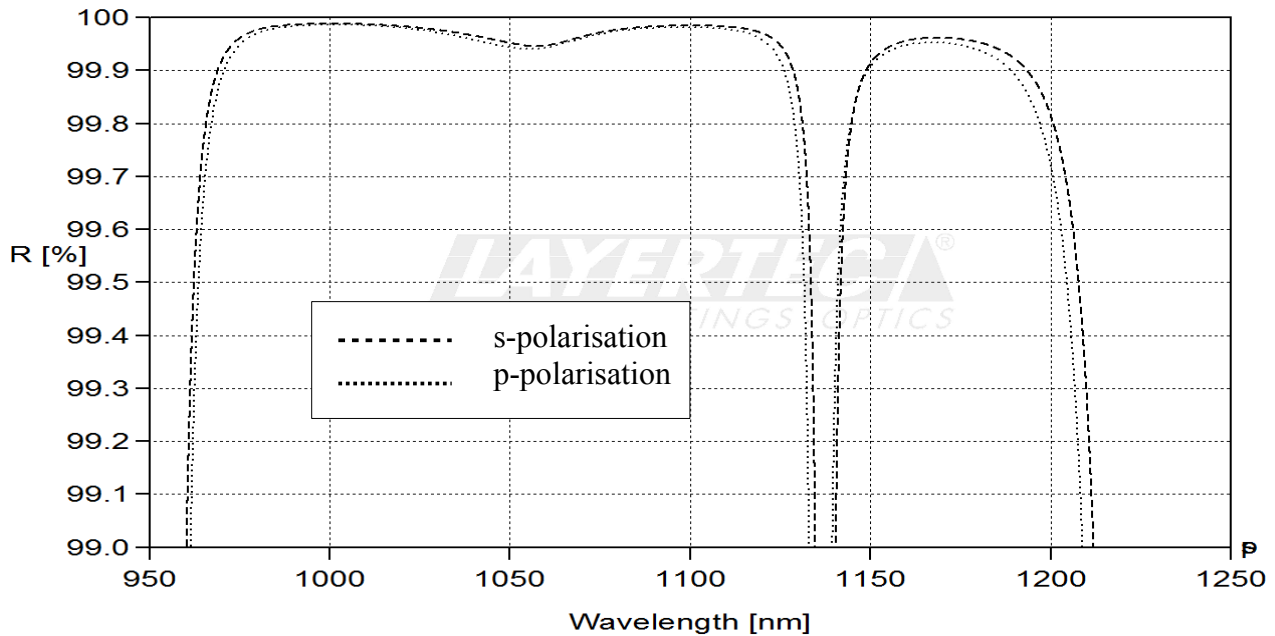


fig. 2 calculated GDD($R,0^\circ$) with typically shift ± 5 nm of ZWL due to the production tolerance

